

Appendix D

Contour Plots

CDMA835 (1013CH)

DUT: ADR8995; Type: BAR; Serial: #1

Communication System: CDMA 835MHz FCC; Frequency: 824.7 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -42.2 dB A/m

Location: -5, 5.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 39.6 dB

ABM1 comp = -2.56 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 5.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.56 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 5.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -47.2 dB A/m

Location: 1.5, -3, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 44.7 dB

ABM1 comp = -2.52 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, -3, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.52 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, -3, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.35 dB A/m

BWC Factor = 0.15103 dB

Location: -0.5, 3.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.38 dB

BWC Factor = 10.8 dB

Location: 1.2, 1.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -37.1 dB A/m

Location: -0.5, 3.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.9 dB

ABM1 comp = 5.88 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 3.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.88 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 3.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

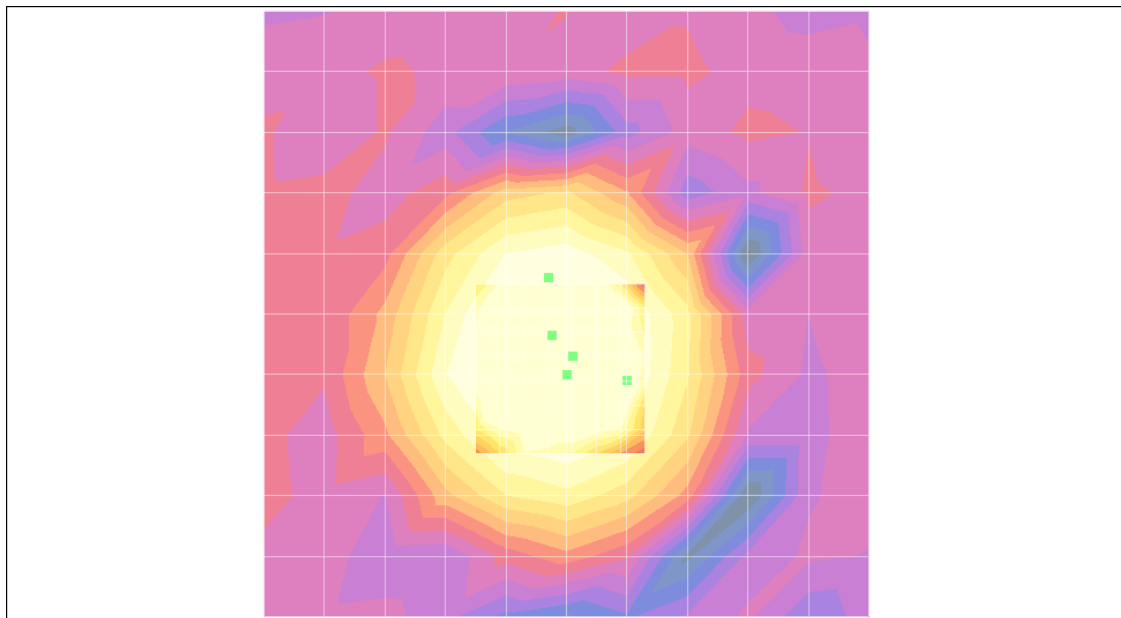
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.31 dB A/m

BWC Factor = 0.15103 dB

Location: 0, 5, 363.7 mm



0 dB = 1.00A/m

CDMA835 (384CH)

DUT: ADR8995; Type: BAR; Serial: #1

Communication System: CDMA 835MHz FCC; Frequency: 836.52 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -41.9 dB A/m

Location: -5, 3.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 38.9 dB

ABM1 comp = -2.94 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 3.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.94 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 3.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -46.7 dB A/m

Location: 3.5, -5, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.8 dB

ABM1 comp = -3.88 dB A/m

BWC Factor = 0.151969 dB

Location: 3.5, -5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.88 dB A/m

BWC Factor = 0.151969 dB

Location: 3.5, -5, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.67 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 4.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.47 dB

BWC Factor = 10.8 dB

Location: 1.2, 2.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -37.5 dB A/m

Location: -0.5, 4.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 43.6 dB

ABM1 comp = 6.04 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 4.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.04 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 4.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

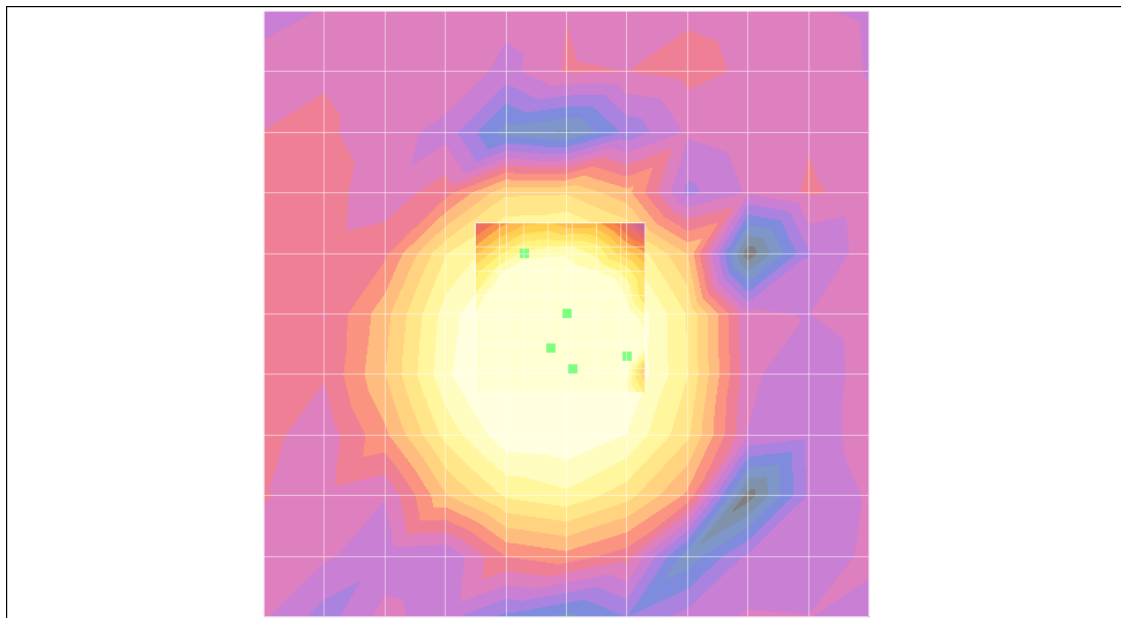
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.54 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 0, 363.7 mm



0 dB = 1.00A/m

CDMA835 (777CH)

DUT: ADR8995; **Type:** BAR; **Serial:** #1

Communication System: CDMA 835MHz FCC; Frequency: 848.31 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -41.3 dB A/m

Location: -5, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 39.3 dB

ABM1 comp = -2.03 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 2.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.03 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 2.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -42.2 dB A/m

Location: 1.5, 12, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 40.1 dB

ABM1 comp = -2.12 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 12, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.12 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 12, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.87 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 3.5, 363.7 mm

Point measurement/z (axial) 300-3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.833 dB

BWC Factor = 10.8 dB

Location: 1.2, 1.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -36.5 dB A/m

Location: -0.5, 3.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.3 dB

ABM1 comp = 5.77 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 3.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.77 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 3.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

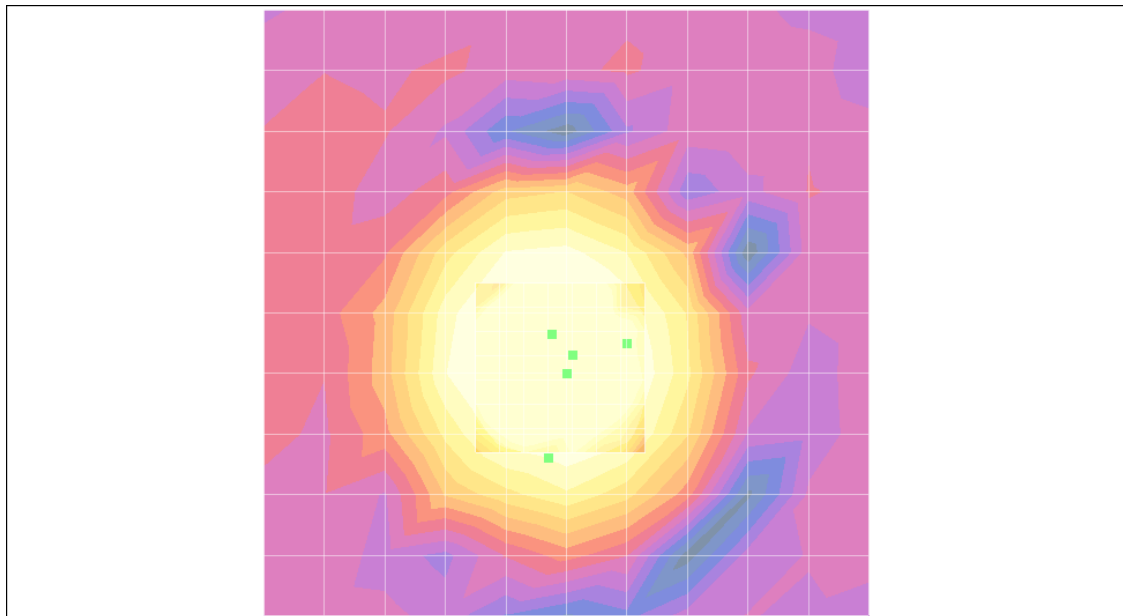
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.37 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 5, 363.7 mm



0 dB = 1.00A/m

PCS1900 (25CH)

DUT: ADR8995; Type: BAR; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1851.25 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -42.1 dB A/m

Location: -5, 6.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 39.2 dB

ABM1 comp = -2.90 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 6.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.90 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 6.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -41.7 dB A/m

Location: 1.5, 12, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 37.7 dB

ABM1 comp = -3.99 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 12, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.99 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 12, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.50 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 5.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.773 dB

BWC Factor = 10.8 dB

Location: 3.2, 3.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -35.2 dB A/m

Location: 1.5, 5.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 40.6 dB

ABM1 comp = 5.34 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 5.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.34 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 5.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

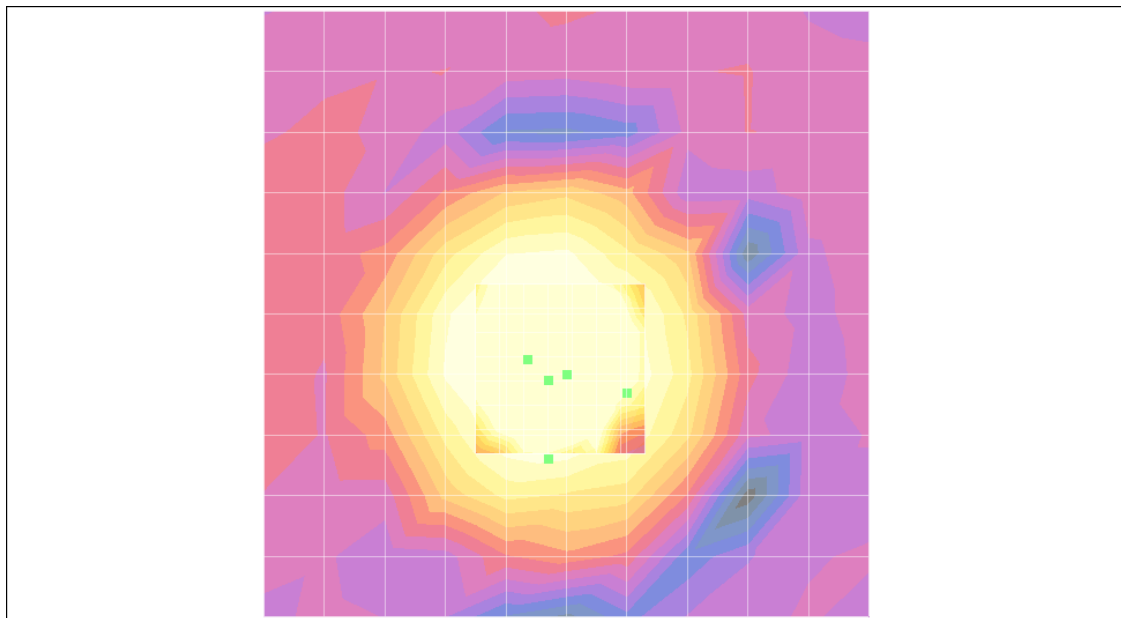
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.07 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 5, 363.7 mm



0 dB = 1.00A/m

PCS1900 (600CH)

DUT: ADR8995; Type: BAR; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1880 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DAS4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DAS4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -42.6 dB A/m

Location: -7, 3.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 40.4 dB

ABM1 comp = -2.16 dB A/m

BWC Factor = 0.151969 dB

Location: -7, 3.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.16 dB A/m

BWC Factor = 0.151969 dB

Location: -7, 3.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -46.0 dB A/m

Location: 3.5, -5, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 42.8 dB

ABM1 comp = -3.17 dB A/m

BWC Factor = 0.151969 dB

Location: 3.5, -5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -3.17 dB A/m

BWC Factor = 0.151969 dB

Location: 3.5, -5, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.28 dB A/m

BWC Factor = 0.151969 dB

Location: 3.5, 3.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 1.02 dB

BWC Factor = 10.8 dB

Location: 5.2, 1.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -33.5 dB A/m

Location: 3.5, 3.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 38.5 dB

ABM1 comp = 5.01 dB A/m

BWC Factor = 0.151969 dB

Location: 3.5, 3.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.01 dB A/m

BWC Factor = 0.151969 dB

Location: 3.5, 3.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

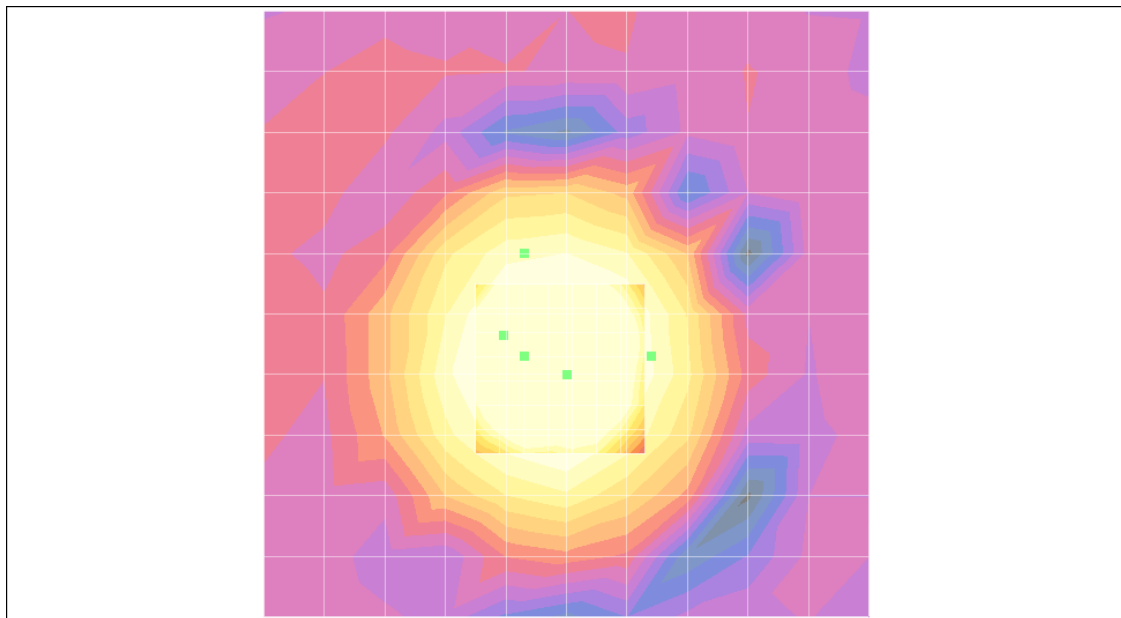
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.02 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 5, 363.7 mm



0 dB = 1.00A/m

PCS1900 (1175CH)

DUT: ADR8995; Type: BAR; Serial: #1

Communication System: PCS 1900MHz FCC; Frequency: 1908.75 MHz; Duty Cycle: 1:1
Medium parameters used: $\sigma = 0$ mho/m, $\epsilon_r = 1$; $\rho = 1$ kg/m³
Phantom section: AMB with Coil Section
Measurement Standard: DASY4 (High Precision Assessment)

DASY4 Configuration:

- Probe: AM1DV2 - 1013; ; Calibrated: 2006-04-18
- Sensor-Surface: 0mm (Fix Surface)
- Electronics: DAE4 Sn869; Calibrated: 2010-09-21
- Phantom: HAC Test Arch with Coil; Type: SD HAC P01 BA; Serial: 1018
- Measurement SW: DASY4, V4.7 Build 71; Postprocessing SW: SEMCAD, V1.8 Build 184

Point measurement/x (longitudinal) at max x/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -41.2 dB A/m

Location: -5, 3.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 38.7 dB

ABM1 comp = -2.52 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 3.5, 363.7 mm

Point measurement/x (longitudinal) at max x/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.52 dB A/m

BWC Factor = 0.151969 dB

Location: -5, 3.5, 363.7 mm

Point measurement/y (transversal) at max y/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -42.8 dB A/m

Location: -0.5, 13, 363.7 mm

Point measurement/y (transversal) at max y/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 39.9 dB

ABM1 comp = -2.91 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 13, 363.7 mm

Point measurement/y (transversal) at max y/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = -2.91 dB A/m

BWC Factor = 0.151969 dB

Location: -0.5, 13, 363.7 mm

Scans/z (axial) 15 x 15/ABM Signal(x,y,z) (8x8x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.08 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 3.5, 363.7 mm

Point measurement/z (axial) 300–3k response at max/ABM Freq Resp(x,y,z,f) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

Diff = 0.580 dB

BWC Factor = 10.8 dB

Location: 3.2, 1.8, 365 mm

Point measurement/z (axial) at max z/ABM Noise(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM2 = -34.3 dB A/m

Location: 1.5, 3.5, 363.7 mm

Point measurement/z (axial) at max z/ABM SNR(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1/ABM2 = 40.6 dB

ABM1 comp = 6.29 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 3.5, 363.7 mm

Point measurement/z (axial) at max z/ABM Signal(x,y,z) (1x1x1):

Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 6.29 dB A/m

BWC Factor = 0.151969 dB

Location: 1.5, 3.5, 363.7 mm

Scans/z (axial) rough 50 x 50/ABM Signal(x,y,z) (11x11x1):

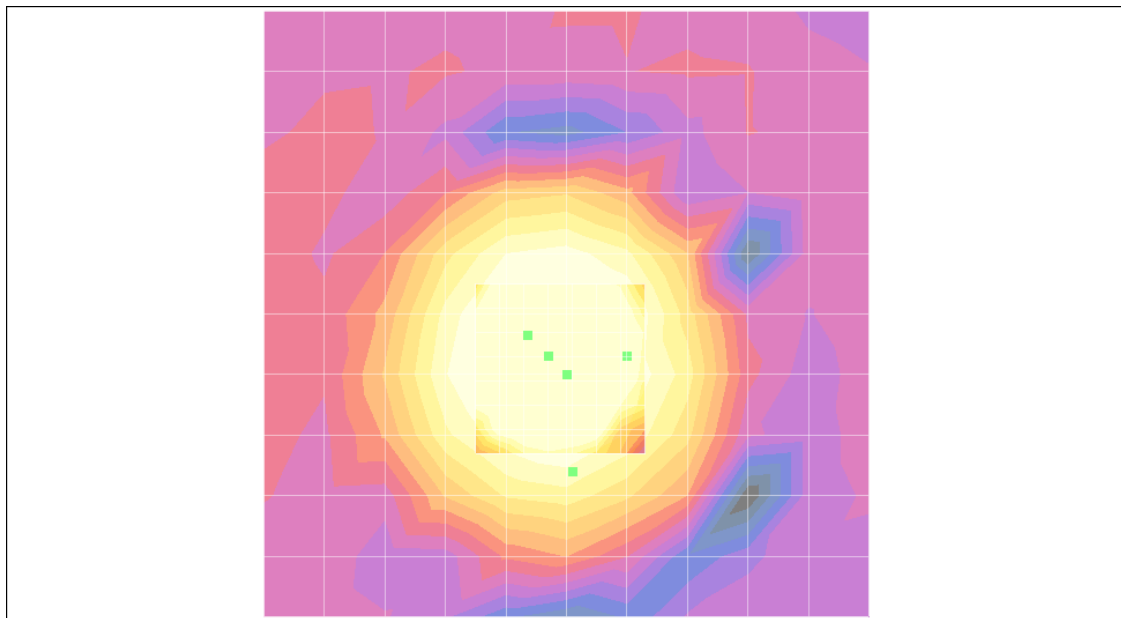
Measurement grid: dx=10mm, dy=10mm

Cursor:

ABM1 comp = 5.62 dB A/m

BWC Factor = 0.151969 dB

Location: 0, 5, 363.7 mm



0 dB = 1.00A/m